## INTEGRATED CIRCUITS



Product specification Supersedes data of 1996 Dec 04 File under Integrated Circuits, IC03 1997 Sep 03



### **TEA1062; TEA1062A**

#### **FEATURES**

- Low DC line voltage; operates down to 1.6 V (excluding) polarity guard)
- · Voltage regulator with adjustable static resistance
- Provides a supply for external circuits
- Symmetrical high-impedance inputs (64 k $\Omega$ ) for dynamic, magnetic or piezoelectric microphones
- Asymmetrical high-impedance input (32 kΩ) for electret microphones
- DTMF signal input with confidence tone
- Mute input for pulse or DTMF dialling
  - TEA1062: active HIGH (MUTE)
  - TEA1062A: active LOW (MUTE)
- · Receiving amplifier for dynamic, magnetic or piezoelectric earpieces
- · Large gain setting ranges on microphone and earpiece amplifiers
- · Line loss compensation (line current dependent) for microphone and earpiece amplifiers
- · Gain control curve adaptable to exchange supply
- DC line voltage adjustment facility.

### QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>LN</sub>	line voltage	I <sub>line</sub> = 15 mA	3.55	4.0	4.25	V
I <sub>line</sub>	operating line current					
	normal operation		11	-	140	mA
	with reduced performance		1	-	11	mA
I <sub>CC</sub>	internal supply current	V <sub>CC</sub> = 2.8 V	_	0.9	1.35	mA
V <sub>CC</sub>	supply voltage for peripherals	I <sub>line</sub> = 15 mA				
	TEA1062	$I_p = 1.2 \text{ mA}; \text{MUTE} = \text{HIGH}$	2.2	2.7	-	V
		I <sub>p</sub> = 0 mA; MUTE = HIGH	_	3.4	_	V
	TEA1062A	$I_p = 1.2 \text{ mA}; \overline{\text{MUTE}} = \text{LOW}$	2.2	2.7	-	V
		I <sub>p</sub> = 0 mA; MUTE = LOW	-	3.4	-	V
Gv	voltage gain					
	microphone amplifier		44	-	52	dB
	receiving amplifier		20	-	31	dB
T <sub>amb</sub>	operating ambient temperature		-25	_	+75	°C
Line loss co	mpensation					
$\Delta G_v$	gain control		—	5.8	-	dB
V <sub>exch</sub>	exchange supply voltage		36	_	60	V
R <sub>exch</sub>	exchange feeding bridge resistance		0.4	_	1	kΩ

1997 Sep 03

The TEA1062 and TEA1062A are integrated circuits that

perform all speech and line interface functions required in fully electronic telephone sets. They perform electronic

switching between dialling and speech. The ICs operate at

line voltage down to 1.6 V DC (with reduced performance)

to facilitate the use of more telephone sets connected in

All statements and values refer to all versions unless

**GENERAL DESCRIPTION** 

parallel.

otherwise specified.

#### Product specification

### TEA1062; TEA1062A

### ORDERING INFORMATION

	PACKAGE						
ITPE NUMBER	NAME	DESCRIPTION	VERSION				
TEA1062	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-1				
TEA1062M1	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4 or SOT38-9				
TEA1062A	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-1				
TEA1062AM1	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4 or SOT38-9				
TEA1062T	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1				
TEA1062AT	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1				

### **BLOCK DIAGRAM**



### PINNING

SYMBOL	PIN	DESCRIPTION
LN	1	positive line terminal
GAS1	2	gain adjustment; transmitting amplifier
GAS2	3	gain adjustment; transmitting amplifier
QR	4	non-inverting output; receiving amplifier
GAR	5	gain adjustment; receiving amplifier
MIC-	6	inverting microphone input
MIC+	7	non-inverting microphone input
STAB	8	current stabilizer
V <sub>EE</sub>	9	negative line terminal
IR	10	receiving amplifier input
DTMF	11	dual-tone multi-frequency input
MUTE	12	mute input (see note 1)
V <sub>CC</sub>	13	positive supply decoupling
REG	14	voltage regulator decoupling
AGC	15	automatic gain control input
SLPE	16	slope (DC resistance) adjustment

## 16 SLPE LN 1 15 AGC GAS1 2

GAS2 3 QR

GAR 5

MIC- 6

STAB 8

MIC +

4

7

Fig.2 Pin configuration for TEA1062A.

MBA354 - 1

TEA1062A

#### Note

1. Pin 12 is active HIGH (MUTE) for TEA1062.

## TEA1062; TEA1062A

14 REG

13 V<sub>CC</sub>

12 MUTE

11 DTMF 10 IR

9 V<sub>EE</sub>

### TEA1062; TEA1062A

### FUNCTIONAL DESCRIPTION

#### Supplies V<sub>CC</sub>, LN, SLPE, REG and STAB

Power for the IC and its peripheral circuits is usually obtained from the telephone line. The supply voltage is derived from the line via a dropping resistor and regulated by the IC. The supply voltage  $V_{CC}$  may also be used to supply external circuits e.g. dialling and control circuits.

Decoupling of the supply voltage is performed by a capacitor between  $V_{CC}$  and  $V_{EE}.$  The internal voltage regulator is decoupled by a capacitor between REG and  $V_{EE}.$ 

The DC current flowing into the set is determined by the exchange supply voltage  $V_{exch}$ , the feeding bridge resistance  $R_{exch}$  and the DC resistance of the telephone line  $R_{line}$ .

The circuit has an internal current stabilizer operating at a level determined by a 3.6 k $\Omega$  resistor connected between STAB and V<sub>EE</sub> (see Fig.9). When the line current (I<sub>line</sub>) is more than 0.5 mA greater than the sum of the IC supply current (I<sub>CC</sub>) and the current drawn by the peripheral circuitry connected to V<sub>CC</sub> (I<sub>p</sub>) the excess current is shunted to V<sub>EE</sub> via LN.

The regulated voltage on the line terminal  $\left(V_{LN}\right)$  can be calculated as:

$$\begin{split} V_{LN} &= V_{ref} + I_{SLPE} \times \text{R9} \\ V_{LN} &= V_{ref} + \{(I_{line} - I_{CC} - 0.5 \times 10^{-3} \text{ A}) - I_{p}\} \times \text{R9} \end{split}$$

 $V_{ref}$  is an internally generated temperature compensated reference voltage of 3.7 V and R9 is an external resistor connected between SLPE and  $V_{\text{EE}}.$ 

In normal use the value of R9 would be 20  $\Omega.$ 

Changing the value of R9 will also affect microphone gain, DTMF gain, gain control characteristics, sidetone level, maximum output swing on LN and the DC characteristics (especially at the lower voltages).

Under normal conditions, when  $I_{SLPE} >> I_{CC} + 0.5 \text{ mA} + I_p$ , the static behaviour of the circuit is that of a 3.7 V regulator diode with an internal resistance equal to that of R9. In the audio frequency range the dynamic impedance is largely determined by R1. Fig.3 shows the equivalent impedance of the circuit.



At line currents below 9 mA the internal reference voltage is automatically adjusted to a lower value (typically 1.6 V at 1 mA). This means that more sets can be operated in parallel with DC line voltages (excluding the polarity guard) down to an absolute minimum voltage of 1.6 V. At line currents below 9 mA the circuit has limited sending and receiving levels. The internal reference voltage can be adjusted by means of an external resistor ( $R_{VA}$ ). This resistor when connected between LN and REG will decrease the internal reference voltage and when connected between REG and SLPE will increase the internal reference voltage.

Current (I<sub>p</sub>) available from V<sub>CC</sub> for peripheral circuits depends on the external components used. Fig.10 shows this current for V<sub>CC</sub> > 2.2 V. If MUTE is LOW (TEA1062) or MUTE is HIGH (TEA1062A) when the receiving amplifier is driven, the available current is further reduced. Current availability can be increased by connecting the supply IC (TEA1081) in parallel with R1 as shown in Fig.19 and Fig.20, or by increasing the DC line voltage by means of an external resistor (R<sub>VA</sub>) connected between REG and SLPE (Fig.18).

## Microphone inputs MIC+ and MIC- and gain pins GAS1 and GAS2

The circuit has symmetrical microphone inputs. Its input impedance is 64 k $\Omega$  (2 × 32 k $\Omega$ ) and its voltage gain is typically 52 dB (when R7 = 68 k $\Omega$ , see Figures 14 and 15). Dynamic, magnetic, piezoelectric or electret (with built-in FET source followers) can be used. Microphone arrangements are illustrated in Fig.11.

The gain of the microphone amplifier can be adjusted between 44 dB and 52 dB to suit the sensitivity of the transducer in use. The gain is proportional to the value of R7 which is connected between GAS1 and GAS2.

Stability is ensured by two external capacitors, C6 connected between GAS1 and SLPE and C8 connected between GAS1 and V<sub>EE</sub>. The value of C6 is 100 pF but this may be increased to obtain a first-order low-pass filter. The value of C8 is 10 times the value of C6. The cut-off frequency corresponds to the time constant R7  $\times$  C6.

### Input MUTE (TEA1062)

When MUTE is HIGH the DTMF input is enabled and the microphone and receiving amplifier inputs are inhibited. The reverse is true when MUTE is LOW or open-circuit. MUTE switching causes only negligible clicking on the line and earpiece output. If the number of parallel sets in use causes a drop in line current to below 6 mA the speech amplifiers remain active independent to the DC level applied to the MUTE input.

### Input MUTE (TEA1062A)

When MUTE is LOW or open-circuit, the DTMF input is enabled and the microphone and receiving amplifier inputs are inhibited. The reverse is true when MUTE is HIGH. MUTE switching causes only negligible clicking on the line and earpiece output. If the number of parallel sets in use causes a drop in line current to below 6 mA the DTMF amplifier becomes active independent to the DC level applied to the MUTE input.

### Dual-tone multi-frequency input DTMF

When the DTMF input is enabled dialling tones may be sent on to the line. The voltage gain from DTMF to LN is typically 25.5 dB (when R7 = 68 k $\Omega$ ) and varies with R7 in the same way as the microphone gain. The signalling tones can be heard in the earpiece at a low level (confidence tone).

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#### Receiving amplifier IR, QR and GAR

The receiving amplifier has one input (IR) and a non-inverting output (QR). Earpiece arrangements are illustrated in Fig.12. The IR to QR gain is typically 31 dB (when R4 = 100 k $\Omega$ ). It can be adjusted between 20 and 31 dB to match the sensitivity of the transducer in use. The gain is set with the value of R4 which is connected between GAR and QR. The overall receive gain, between LN and QR, is calculated by subtracting the anti-sidetone network attenuation (32 dB) from the amplifier gain. Two external capacitors, C4 and C7, ensure stability. C4 is normally 100 pF and C7 is 10 times the value of C4. The value of C4 may be increased to obtain a first-order low-pass filter. The cut-off frequency will depend on the time constant R4 × C4.

The output voltage of the receiving amplifier is specified for continuous-wave drive. The maximum output voltage will be higher under speech conditions where the peak to RMS ratio is higher.

### Automatic Gain Control input AGC

Automatic line loss compensation is achieved by connecting a resistor (R6) between AGC and  $V_{EE}$ .

The automatic gain control varies the gain of the microphone amplifier and the receiving amplifier in accordance with the DC line current. The control range is 5.8 dB which corresponds to a line length of 5 km for a 0.5 mm diameter twisted-pair copper cable with a DC resistance of 176  $\Omega$ /km and average attenuation of 1.2 dB/km). Resistor R6 should be chosen in accordance with the exchange supply voltage and its feeding bridge resistance (see Fig.13 and Table 1). The ratio of start and stop currents of the AGC curve is independent of the value of R6. If no automatic line-loss compensation is required the AGC pin may be left open-circuit. The amplifiers, in this condition, will give their maximum specified gain.

### TEA1062; TEA1062A

#### Sidetone suppression

The anti-sidetone network,  $R1//Z_{line}$ , R2, R3, R8, R9 and  $Z_{bal}$ , (see Fig.4) suppresses the transmitted signal in the earpiece. Maximum compensation is obtained when the following conditions are fulfilled:

$$R9 \times R2 = R1 \times \left(R3 + \frac{R8 \times Z_{bal}}{R8 + Z_{bal}}\right)$$
(1)

$$\frac{Z_{bal}}{Z_{bal} + R8} = \frac{Z_{line}}{Z_{line} + R1}$$
(2)

If fixed values are chosen for R1, R2, R3 and R9, then condition (1) will always be fulfilled when  $|R8//Z_{bal}| \ll R3$ .

To obtain optimum sidetone suppression, condition (2) has to be fulfilled which results in:

$$Z_{bal} = \frac{R8}{R1} \times Z_{line} = k \times Z_{line}$$

Where k is a scale factor;  $k = \frac{R8}{R1}$ 

The scale factor k, dependent on the value of R8, is chosen to meet the following criteria:

- compatibility with a standard capacitor from the E6 or E12 range for  $Z_{\text{bal}}$
- |Z<sub>bal</sub>//R8| << R3 fulfilling condition (a) and thus ensuring correct anti-sidetone bridge operation
- $|Z_{bal} + R8| >> R9$  to avoid influencing the transmit gain.

In practise  $Z_{\text{line}}$  varies considerably with the line type and length. The value chosen for  $Z_{\text{bal}}$  should therefore be for an average line length thus giving optimum setting for short or long lines.

#### EXAMPLE

The balance impedance  $Z_{bal}$  at which the optimum suppression is present can be calculated by:

Suppose  $Z_{\text{line}} = 210 \ \Omega + (1265 \ \Omega//140 \text{ nF})$  representing a 5 km line of 0.5 mm diameter, copper, twisted-pair cable matched to 600  $\Omega$  (176  $\Omega/\text{km}$ ; 38 nF/km).

When k = 0.64 then R8 = 390  $\Omega$ ; Z<sub>bal</sub> = 130  $\Omega$  + (820  $\Omega$ //220 nF).

The anti-sidetone network for the TEA1060 family shown in Fig.4 attenuates the signal received from the line by 32 dB before it enters the receiving amplifier. The attenuation is almost constant over the whole audio-frequency range.

Figure 5 shows a conventional Wheatstone bridge anti-sidetone circuit that can be used as an alternative. Both bridge types can be used with either resistive or complex set impedances. (More information on the balancing of anti-sidetone bridges can be obtained in our publication *"Applications Handbook for Wired telecom systems, IC03b"*, order number 9397 750 00811.)





#### Product specification

### TEA1062; TEA1062A

### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>LN</sub>	positive continuous line voltage		_	12	V
V <sub>LN(R)</sub>	repetitive line voltage during switch-on or line interruption		_	13.2	V
V <sub>LN(RM)</sub>	repetitive peak line voltage for a 1 ms pulse per 5 s	R9 = 20 Ω; R10 = 13 Ω; see Fig.18	_	28	V
I <sub>line</sub>	line current	R9 = 20 Ω; note 1	_	140	mA
VI	input voltage on all other pins	positive input voltage	_	V <sub>CC</sub> + 0.7	V
		negative input voltage	_	-0.7	V
P <sub>tot</sub>	total power dissipation	R9 = 20 Ω; note 2			
	TEA1062; TEA1062A		-	666	mW
	TEA1062M1; TEA1062AM1		-	617	mW
	TEA1062T; TEA1062AT		_	454	mW
T <sub>amb</sub>	operating ambient temperature		-25	+75	°C
T <sub>stg</sub>	storage temperature		-40	+125	°C
Tj	junction temperature		_	125	°C

#### Notes

- 1. Mostly dependent on the maximum required T<sub>amb</sub> and on the voltage between LN and SLPE (see Figs 6, 7 and 8).
- Calculated for the maximum ambient temperature specified (T<sub>amb</sub> = 75 °C) and a maximum junction temperature of 125 °C.

#### HANDLING

This device meets class 2 ESD test requirements [Human Body Model (HBM)], in accordance with *"MIL STD 883C - method 3015"*.

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R <sub>th j-a</sub>	thermal resistance from junction to ambient in free air		
	TEA1062; TEA1062A	75	K/W
	TEA1062M1; TEA1062AM1	81	K/W
	TEA1062T; TEA1062AT (note 1)	110	K/W

#### Note

1. Mounted on glass epoxy board  $28.5 \times 19.1 \times 1.5$  mm.







### TEA1062; TEA1062A

### CHARACTERISTICS

 $I_{line}$  = 11 to 140 mA;  $V_{EE}$  = 0 V; f = 800 Hz;  $T_{amb}$  = 25 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supplies	LN and V <sub>CC</sub> (pins 1 and 13)				1	4
V <sub>LN</sub>	voltage drop over circuit between LN	MIC inputs open-circuit				
	and V <sub>EE</sub>	I <sub>line</sub> = 1 mA	_	1.6	_	V
		I <sub>line</sub> = 4 mA	_	1.9	_	V
		I <sub>line</sub> = 15 mA	3.55	4.0	4.25	V
		I <sub>line</sub> = 100 mA	4.9	5.7	6.5	V
		I <sub>line</sub> = 140 mA	_	_	7.5	V
$\Delta V_{LN} / \Delta T$	variation with temperature	I <sub>line</sub> = 15 mA	_	-0.3	-	mV/K
V <sub>LN</sub>	voltage drop over circuit between LN	I <sub>line</sub> = 15 mA				
	and $V_{\text{EE}}$ with external resistor $R_{\text{VA}}$	$R_{VA}$ (LN to REG) = 68 k $\Omega$	_	3.5	_	V
		R <sub>VA</sub> (REG to SLPE) = 39 k $\Omega$	_	4.5	_	V
I <sub>CC</sub>	supply current	V <sub>CC</sub> = 2.8 V	_	0.9	1.35	mA
V <sub>CC</sub>	supply voltage available for peripheral circuitry	I <sub>line</sub> = 15 mA; MUTE = HIGH				
	TEA1062	I <sub>p</sub> = 1.2 mA	2.2	2.7	_	V
		$I_p = 0 \text{ mA}$	_	3.4	_	V
V <sub>CC</sub>	supply voltage available for peripheral circuitry	I <sub>line</sub> = 15 mA; MUTE = LOW				
	TEA1062A	$I_{p} = 1.2 \text{ mA}$	2.2	2.7	_	V
		$I_p = 0 \text{ mA}$	_	3.4	_	V
Micropho	ne inputs MIC– and MIC+ (pins 6 and 7	)				-
Z <sub>i</sub>	input impedance					
	differential	between MIC- and MIC+	-	64	_	kΩ
	single-ended	MIC- or MIC+ to V <sub>EE</sub>	-	32	_	kΩ
CMRR	common mode rejection ratio		-	82	-	dB
Gv	voltage gain MIC+ or MIC- to LN	I <sub>line</sub> = 15 mA; R7 = 68 kΩ	50.5	52.0	53.5	dB
$\Delta G_{vf}$	gain variation with frequency referenced to 800 Hz	f = 300 and 3400 Hz	-	±0.2	-	dB
$\Delta G_{vT}$	gain variation with temperature referenced to 25 °C	without R6; $I_{line} = 50 \text{ mA}$ ; $T_{amb} = -25 \text{ and } +75 ^{\circ}\text{C}$	-	±0.2	-	dB
DTMF inp	ut (pin 11)					-
Z <sub>i</sub>	input impedance		-	20.7	-	kΩ
Gv	voltage gain from DTMF to LN	l <sub>line</sub> = 15 mA; R7 = 68 kΩ	24.0	25.5	27.0	dB
$\Delta G_{vf}$	gain variation with frequency referenced to 800 Hz	f = 300 and 3400 Hz	-	±0.2	-	dB
$\Delta G_{vT}$	gain variation with temperature referenced to 25 °C	$I_{line} = 50 \text{ mA};$ $T_{amb} = -25 \text{ and } +75 \text{ °C}$	-	±0.2	-	dB

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Gain adju	stment inputs GAS1 and GAS2 (pins 2	and 3)	-!	1		
$\Delta G_{v}$	transmitting amplifier gain variation by adjustment of R7 between GAS1 and GAS2		-8	-	0	dB
Sending a	implifier output LN (pin 1)				•	
V <sub>LN(rms)</sub>	output voltage (RMS value)	THD = 10%				
		I <sub>line</sub> = 4 mA	-	0.8	-	V
		I <sub>line</sub> = 15 mA	1.7	2.3	_	V
V <sub>no(rms)</sub>	noise output voltage (RMS value)	$I_{line} = 15 \text{ mA}; \text{R7} = 68 \text{ k}\Omega;$ 200 $\Omega$ between MIC– and MIC+; psophometrically weighted (P53 curve)	-	-69	-	dBmp
Receiving	amplifier input IR (pin 10)		·			
Z <sub>i</sub>	input impedance		_	21	-	kΩ
Receiving	amplifier output QR (pin 4)					
Z <sub>o</sub>	output impedance		_	4	-	Ω
Gv	voltage gain from IR to QR	$I_{line} = 15 \text{ mA}; \text{ R}_{L} = 300 \Omega$ (from pin 9 to pin 4)	29.5	31	32.5	dB
$\Delta G_{vf}$	gain variation with frequency referenced to 800 Hz	f = 300 and 3400 Hz	-	±0.2	-	dB
$\Delta G_{vT}$	gain variation with temperature referenced to 25 °C	without R6; I <sub>line</sub> = 50 mA; T <sub>amb</sub> = –25 and +75 °C	-	±0.2	-	dB
V <sub>o(rms)</sub>	output voltage (RMS value)	THD = 2%; sine wave drive; R4 = 100 k $\Omega$ ; I <sub>line</sub> = 15 mA; I <sub>p</sub> = 0 mA				
		$R_L = 150 \Omega$	0.22	0.33	-	V
		R <sub>L</sub> = 450 Ω	0.3	0.48	-	V
V <sub>o(rms)</sub>	output voltage (RMS value)	THD = 10%; R4 = 100 kΩ; R <sub>L</sub> = 150 Ω; I <sub>line</sub> = 4 mA	-	15	-	mV
V <sub>no(rms)</sub>	noise output voltage (RMS value)	$I_{line} = 15 \text{ mA}; \text{R4} = 100 \text{ k}\Omega;$ IR open-circuit psophometrically weighted (P53 curve); R <sub>L</sub> = 300 $\Omega$	_	50	-	μV
Gain adju	stment input GAR (pin 5)					
$\Delta G_v$	receiving amplifier gain variation by adjustment of R4 between GAR and QR		-11	-	0	dB
Mute inpu	t (pin 12)					•
V <sub>IH</sub>	HIGH level input voltage		1.5	-	V <sub>CC</sub>	V
V <sub>IL</sub>	LOW level input voltage			-	0.3	V
IMUTE	input current		_	8	15	μA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Reductior	n of gain				•	•
$\Delta G_v$	MIC+ or MIC- to LN					
	TEA1062	MUTE = HIGH	-	70	_	dB
	TEA1062A	MUTE = LOW	-	70	_	dB
Gv	voltage gain from DTMF to QR	R4 = 100 kΩ; R <sub>L</sub> = 300 Ω				
	TEA1062	MUTE = HIGH	-	-17	_	dB
	TEA1062A	$\overline{MUTE} = LOW$	-	-17	_	dB
Automatic	gain control input AGC (pin 15)					
$\Delta G_v$	controlling the gain from IR to QR and the gain from MIC+, MIC– to LN gain control range	R6 = 110 kΩ (between AGC and V <sub>EE</sub> ) $I_{line} = 70$ mA	_	-5.8	_	dB
I <sub>lineH</sub>	highest line current for maximum gain		-	23	-	mA
I <sub>lineL</sub>	lowest line current for minimum gain		-	61	_	mA











Table 1	Values of resistor R6 for optimum line-loss compensation at various values of exchange supply voltage
	$(V_{exch})$ and exchange feeding bridge resistance $(R_{exch})$ ; R9 = 20 $\Omega$ .

	R6 (kΩ)						
V <sub>exch</sub> (V)	$R_{exch}$ = 400 $\Omega$	$R_{exch}$ = 600 $\Omega$	R <sub>exch</sub> = 800 Ω	$R_{exch}$ = 1000 $\Omega$			
36	100	78.7	_	_			
48	140	110	93.1	82			
60	_	_	120	102			









### **APPLICATION INFORMATION**







SOT38-1

050G09

MO-001AE

## Low voltage transmission circuits with dialler interface

### PACKAGE OUTLINES

### DIP16: plastic dual in-line package; 16 leads (300 mil); long body



92-10-02

95-01-19

 $\bigcirc$ 

SOT38-1

#### DIP16: plastic dual in-line package; 16 leads (300 mil)



OUTLINE	REFERENCES				EUROPEAN		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE	
SOT38-4						<del>-92-11-17</del> 95-01-14	

SOT38-4

### DIP16: plastic dual in-line package; 16 leads (300 mil)



OUTLINE	REFERENCES			EUROPEAN		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT38-9						97-07-24

Product specification

SOT38-9

SOT109-1

### Low voltage transmission circuits with dialler interface

SO16: plastic small outline package; 16 leads; body width 3.9 mm



IEC

076E07S

MS-012AC



95-01-23

97-05-22

 $\bigcirc$ 

SOT109-1

### TEA1062; TEA1062A

#### SOLDERING

#### Plastic dual in-line packages

#### BY DIP OR WAVE

The maximum permissible temperature of the solder is 260 °C; this temperature must not be in contact with the joint for more than 5 s. The total contact time of successive solder waves must not exceed 5 s.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified storage maximum. If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

#### REPAIRING SOLDERED JOINTS

Apply the soldering iron below the seating plane (or not more than 2 mm above it). If its temperature is below  $300 \,^{\circ}$ C, it must not be in contact for more than 10 s; if between 300 and 400  $^{\circ}$ C, for not more than 5 s.

#### Plastic small-outline packages

#### BY WAVE

During placement and before soldering, the component must be fixed with a droplet of adhesive. After curing the adhesive, the component can be soldered. The adhesive can be applied by screen printing, pin transfer or syringe dispensing.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder bath is 10 s, if allowed to cool to less than 150 °C within 6 s. Typical dwell time is 4 s at 250 °C.

A modified wave soldering technique is recommended using two solder waves (dual-wave), in which a turbulent wave with high upward pressure is followed by a smooth laminar wave. Using a mildly-activated flux eliminates the need for removal of corrosive residues in most applications.

#### BY SOLDER PASTE REFLOW

Reflow soldering requires the solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the substrate by screen printing, stencilling or pressure-syringe dispensing before device placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt, infrared, and vapour-phase reflow. Dwell times vary between 50 and 300 s according to method. Typical reflow temperatures range from 215 to 250 °C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 min at 45 °C.

REPAIRING SOLDERED JOINTS (BY HAND-HELD SOLDERING IRON OR PULSE-HEATED SOLDER TOOL)

Fix the component by first soldering two, diagonally opposite, end pins. Apply the heating tool to the flat part of the pin only. Contact time must be limited to 10 s at up to  $300 \,^{\circ}$ C. When using proper tools, all other pins can be soldered in one operation within 2 to 5 s at between 270 and 320  $^{\circ}$ C. (Pulse-heated soldering is not recommended for SO packages.)

For pulse-heated solder tool (resistance) soldering of VSO packages, solder is applied to the substrate by dipping or by an extra thick tin/lead plating before package placement.

### TEA1062; TEA1062A

### DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	

Where application information is given, it is advisory and does not form part of the specification.

### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

## Philips Semiconductors – a worldwide company

Argentina: see South America Australia: 34 Waterloo Road, NORTH RYDE, NSW 2113, Tel. +61 2 9805 4455, Fax. +61 2 9805 4466 Austria: Computerstr. 6, A-1101 WIEN, P.O. Box 213, Tel. +43 1 60 101, Fax. +43 1 60 101 1210 Belarus: Hotel Minsk Business Center, Bld. 3, r. 1211, Volodarski Str. 6, 220050 MINSK, Tel. +375 172 200 733, Fax. +375 172 200 773 Belgium: see The Netherlands Brazil: see South America Bulgaria: Philips Bulgaria Ltd., Energoproject, 15th floor, 51 James Bourchier Blvd., 1407 SOFIA, Tel. +359 2 689 211, Fax. +359 2 689 102 Canada: PHILIPS SEMICONDUCTORS/COMPONENTS, Tel. +1 800 234 7381 China/Hong Kong: 501 Hong Kong Industrial Technology Centre, 72 Tat Chee Avenue, Kowloon Tong, HONG KONG, Tel. +852 2319 7888, Fax. +852 2319 7700 Colombia: see South America Czech Republic: see Austria Denmark: Prags Boulevard 80, PB 1919, DK-2300 COPENHAGEN S, Tel. +45 32 88 2636. Fax. +45 31 57 1949 Finland: Sinikalliontie 3. FIN-02630 ESPOO. Tel. +358 9 615800, Fax. +358 9 61580/xxx France: 4 Rue du Port-aux-Vins, BP317, 92156 SURESNES Cedex, Tel. +33 1 40 99 6161, Fax. +33 1 40 99 6427 Germany: Hammerbrookstraße 69, D-20097 HAMBURG, Tel. +49 40 23 53 60, Fax. +49 40 23 536 300 Greece: No. 15, 25th March Street, GR 17778 TAVROS/ATHENS, Tel. +30 1 4894 339/239, Fax. +30 1 4814 240 Hungary: see Austria India: Philips INDIA Ltd, Shivsagar Estate, A Block, Dr. Annie Besant Rd. Worli, MUMBAI 400 018, Tel. +91 22 4938 541, Fax. +91 22 4938 722 Indonesia: see Singapore Ireland: Newstead, Clonskeagh, DUBLIN 14, Tel. +353 1 7640 000, Fax. +353 1 7640 200 Israel: RAPAC Electronics, 7 Kehilat Saloniki St. TEL AVIV 61180. Tel. +972 3 645 0444, Fax. +972 3 649 1007 Italy: PHILIPS SEMICONDUCTORS, Piazza IV Novembre 3, 20124 MILANO, Tel. +39 2 6752 2531, Fax. +39 2 6752 2557 Japan: Philips Bldg 13-37, Kohnan 2-chome, Minato-ku, TOKYO 108, Tel. +81 3 3740 5130, Fax. +81 3 3740 5077 Korea: Philips House, 260-199 Itaewon-dong, Yongsan-ku, SEOUL, Tel. +82 2 709 1412, Fax. +82 2 709 1415

Malaysia: No. 76 Jalan Universiti, 46200 PETALING JAYA, SELANGOR, Tel. +60 3 750 5214, Fax. +60 3 757 4880

Mexico: 5900 Gateway East, Suite 200, EL PASO, TEXAS 79905, Tel. +9-5 800 234 7381

Middle East: see Italy

Netherlands: Postbus 90050, 5600 PB EINDHOVEN, Bldg. VB, Tel. +31 40 27 82785, Fax. +31 40 27 88399

New Zealand: 2 Wagener Place, C.P.O. Box 1041, AUCKLAND, Tel. +64 9 849 4160, Fax. +64 9 849 7811

Norway: Box 1, Manglerud 0612, OSLO, Tel. +47 22 74 8000, Fax. +47 22 74 8341

Philippines: Philips Semiconductors Philippines Inc., 106 Valero St. Salcedo Village, P.O. Box 2108 MCC, MAKATI, Metro MANILA, Tel. +63 2 816 6380, Fax. +63 2 817 3474 Poland: Ul. Lukiska 10, PL 04-123 WARSZAWA,

Tel. +48 22 612 2831, Fax. +48 22 612 2327

Portugal: see Spain

Romania: see Italy

Russia: Philips Russia, UI. Usatcheva 35A, 119048 MOSCOW, Tel. +7 095 247 9145, Fax. +7 095 247 9144

Singapore: Lorong 1, Toa Payoh, SINGAPORE 1231, Tel. +65 350 2538, Fax. +65 251 6500

Slovakia: see Austria

Slovenia: see Italy

South Africa: S.A. PHILIPS Pty Ltd., 195-215 Main Road Martindale, 2092 JOHANNESBURG, P.O. Box 7430 Johannesburg 2000, Tel. +27 11 470 5911, Fax. +27 11 470 5494

South America: Rua do Rocio 220, 5th floor, Suite 51, 04552-903 São Paulo, SÃO PAULO - SP, Brazil, Tel. +55 11 821 2333, Fax. +55 11 829 1849

Spain: Balmes 22, 08007 BARCELONA, Tel. +34 3 301 6312, Fax. +34 3 301 4107

Sweden: Kottbygatan 7, Akalla, S-16485 STOCKHOLM, Tel. +46 8 632 2000, Fax. +46 8 632 2745

Switzerland: Allmendstrasse 140, CH-8027 ZÜRICH, Tel. +41 1 488 2686, Fax. +41 1 481 7730

Taiwan: PHILIPS TAIWAN Ltd., 23-30F, 66, Chung Hsiao West Road, Sec. 1, P.O. Box 22978, TAIPEI 100, Tol. 1996 2, 282, 4442, Eox. 1996 2, 282, 444

TAIPEI 100, Tel. +886 2 382 4443, Fax. +886 2 382 4444 Thailand: PHILIPS ELECTRONICS (THAILAND) Ltd.,

209/2 Sanpavuth-Bangna Road Prakanong, BANGKOK 10260, Tel. +66 2 745 4090, Fax. +66 2 398 0793

Turkey: Talatpasa Cad. No. 5, 80640 GÜLTEPE/ISTANBUL, Tel. +90 212 279 2770, Fax. +90 212 282 6707

Ukraine: PHILIPS UKRAINE, 4 Patrice Lumumba str., Building B, Floor 7, 252042 KIEV, Tel. +380 44 264 2776, Fax. +380 44 268 0461 United Kingdom: Philips Semiconductors Ltd., 276 Bath Road, Hayes,

MIDDLESEX UB3 5BX, Tel. +44 181 730 5000, Fax. +44 181 754 8421 United States: 811 East Arques Avenue, SUNNYVALE, CA 94088-3409, Tel. +1 800 234 7381

Uruguay: see South America

Vietnam: see Singapore

Yugoslavia: PHILIPS, Trg N. Pasica 5/v, 11000 BEOGRAD, Tel. +381 11 625 344, Fax.+381 11 635 777

For all other countries apply to: Philips Semiconductors, Marketing & Sales Communications, Building BE-p, P.O. Box 218, 5600 MD EINDHOVEN, The Netherlands, Fax. +31 40 27 24825 Internet: http://www.semiconductors.philips.com

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